## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

LICANTS:

MICHAEL TEWES ET AL

EXAMINER: SHUN LEE

R. NO.

09/319,092

GROUP:

2878

FILED:

June 18, 1999

FOR: FLUORESCENCE CORRELATION SPECTROSCOPY MODULE FOR A

MICROSCOPE

## SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

MAIL STOP: AF

Commissioner for Patents

P.O. Box 1450

Alexandria, VA 22313-1450

Sir:

Applicants are submitting Form PTO 1449 and the references cited This Information Disclosure Statement (IDS) contains articles previously submitted in an IDS, but now being presented in a more legible copy.

If it is determined that a fee is due, the Commissioner is hereby authorized to charge our deposit account number 03-2468, without further authorization.

It is respectfully requested that this Information Disclosure Statement be considered and placed into the application file.

Respectfully submitted,

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Enclosure: FORM PTO-1449 with copies of (13) listed references

I hereby certify that this correspondence is being deposited with the U.S. Postal Service as first class mail in an envelope addressed to: MAIL STOP AF, Commissioner of Patents, U.S. PTO, P.O. Box 1450, Alexandria, VA 22313-1450, on August 29, 2003.

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